



# Test Report: SD-15B-12

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15W DC-DC Single Output Switching Power Supply

## ■ DESIGN VERIFY TEST

Output Function Test

Input Function Test

Protection Function Test

Component Stress Test

## ■ SAFETY & E.M.C. TEST

Safety Test

E.M.C. Test

## ■ RELIABILITY TEST

ENVIRONMENT TEST

■ DESIGN VERIFY TEST

**OUTPUT FUNCTION TEST**

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	RIPPLE & NOISE	V1 : 120 mVp-p (Max)	I/P : 24VDC O/P : FULL LOAD Ta : 25°C	V1 : 31 mVp-p (Max)	P
2	OUTPUT VOLTAGE ADJUST RANGE	CH1 : 10.8 V ~ 13.2 V	I/P : 24 VDC O/P : MIN LOAD Ta : 25°C	10.39 V ~ 13.95 V / 24 VDC	P
3	OUTPUT VOLTAGE TOLERANCE	V1 : 2 % - 2 % (Max)	I/P : 18 VDC ~ 36 VDC O/P : FULL / MIN LOAD Ta : 25°C	V1 : 0.05 % ~ -0.11 %	P
4	LINE REGULATION	V1 : 0.3 % - 0.3 % (Max)	I/P : 18 VDC ~ 36 VDC O/P : FULL LOAD Ta : 25°C	V1 : 0.05 % ~ 0 %	P
5	LOAD REGULATION	V1 : 0.3 % - 0.3 % (Max)	I/P : 24 VDC O/P : FULL ~ MIN LOAD Ta : 25°C	V1 : 0.05 % ~ -0.15 %	P
6	SET UP TIME	24VDC : 2500 ms (Max)	I/P : 24 VDC O/P : FULL LOAD Ta : 25°C	24VDC / 1673 ms	P
7	RISE TIME	24VDC : 25 ms (Max)	I/P : 24 VDC O/P : FULL LOAD Ta : 25°C	24VDC / 5 ms	P
8	OVER/UNDERSHOOT TEST	< ± 5 %	I/P : 24 VDC O/P : FULL LOAD Ta : 25°C	TEST : < 5 %	P
9	DYNAMIC LOAD	V1 : 1200 mVp-p	I/P : 24 VDC (1).O/P : FULL /Min LOAD 90%DUTY/ 1KHZ (2).O/P : FULL /Min LOAD 50%DUTY/ 120HZ Ta : 25°C	(1) 224 mVp-p (2) 726 mVp-p	P

**INPUT FUNCTION TEST**

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	INPUT VOLTAGE RANGE	18VDC~36VDC	I/P : TESTING O/P : FULL LOAD Ta : 25°C	17.8 V~36V	P
			I/P : LOW-LINE-0.2V=17.8 V HIGH-LINE+ 5%=37.8 V O/P : FULL/MIN LOAD ON : 30 Sec . OFF : 30 Sec 10MIN ( AC POWER ON/OFF NO DAMAGE )	TEST : OK	
2	EFFICIENCY	76 % (TYP)	I/P : 24 VDC O/P : FULL LOAD Ta : 25°C	78.93 %	P
3	INPUT CURRENT	24VDC/ 0.9 A (TYP)	I/P : 24 VDC O/P : FULL LOAD Ta : 25°C	I = 0.791 A/ 24 VDC	P

**PROTECTION FUNCTION TEST**

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	OVER LOAD PROTECTION	105 % ~ 160 %	I/P : 24 VDC O/P : TESTING Ta : 25°C	135.61 %/ 24 VDC  Hiccup Mode	P
2	OVER VOLTAGE PROTECTION	CH1 : 13.8 V ~ 16.2 V	I/P : 24 VDC O/P : 10% LOAD Ta : 25°C	14.56 V/ 24 VDC  Shut off o/p voltage, clamping by zener diode	P
3	SHORT PROTECTION	SHORT EVERY OUTPUT 1 HOUR NO DAMAGE	I/P : 36 VDC O/P : FULL LOAD Ta : 25°C	NO DAMAGE  Hiccup Mode	P

**COMPONENT STRESS TEST**

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	Power Transistor (D to S) or (C to E) Peak Voltage	Q1 Rated : IRF640 : 200 V/ 18 A	I/P : High-Line +3V = 39 V O/P : (1)Full Load Turn on (2) Output Short (3)Full load continue Ta : 25°C	(1) 149 V (2) 137 V (3) 146 V	P
2	Diode Peak Voltage	D10 Rated : BYQ28X-200 :200V/ 10 A	I/P : High-Line +3V = 39 V O/P : (1)Full Load Turn on (2)Output Short (3)Full load continue Ta : 25°C	(1) 154 V (2) 138 V (3) 143 V	P
3	Input Capacitor Voltage	C5 Rated : 220u/63V 105°C 10*20 GL	I/P : High-Line +3V = 39 V O/P : (1)Full Load Turn on /Off (2) Min load Turn on /Off (3)Full Load /Min load Change Ta : 25°C	(1) 41.6 V (2) 41.6 V (3) 41.0 V	P
4	Control IC Voltage Test	U 1 Rated : TL3845P: 30V (MAX)	I/P : High-Line +3V = 39 V O/P : (1)Full Load Turn on /Off (2) Min load Turn on /Off (3)Full Load /Min load Change Ta : 25°C	(1) 13.7 V (2) 12.5 V (3) 13.7 V	P

**SAFETY & E.M.C. TEST**

**SAFETY TEST**

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	WITHSTAND VOLTAGE	I/P-FG: 1.5 KVAC/min I/P-O/P: 1.5 KVAC/min O/P-FG: 0.5 KVAC/min EN 60950	I/P-FG: 1.8 KVAC/min I/P-O/P: 1.8 KVAC/min O/P-FG: 0.6 KVAC/min Ta:25°C	I/P-FG : 3.22 mA I/P-O/P : 0.64 mA O/P-FG : 0.28 mA NO DAMAGE	P
2	ISOLATION RESISTANCE	I/P-FG: 500VDC>100MΩ I/P-O/P:500VDC>100MΩ O/P-FG:500VDC>100MΩ	I/P-FG: 500 VDC I/P-O/P: 500 VDC O/P-FG: 500 VDC Ta : 25°C /70%RH	I/P-FG : >9999 MΩ I/P-O/P : >9999 MΩ O/P-FG : >9999 MΩ NO DAMAGE	P
3	GROUNDING CONTINUITY	FG(PE) TO CHASSIS OR TRACE < 100 mΩ EN 60950	40 A / 1min Ta:25°C	6 mΩ	P

**E.M.C TEST**

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
3	RADIATION	EN55022 CLASSB	I/P: 24 VDC O/P: FULL LOAD Ta:25°C	PASS Test by certified Lab	P
4	E.S.D	EN61000-4-2 LIGHT INDUSTRY AIR:8KV / Contact:4KV	I/P: 24 VDC O/P:FULL LOAD Ta:25°C	CRITERIA A	P
5	E.F.T	EN61000-4-4 LIGHT INDUSTRY INPUT: 1KV	I/P: 24 VDC O/P:FULL LOAD Ta:25°C	CRITERIA A	P
7	Test by certified Lab & Test Report Prepare				

■ **RELIABILITY TEST**

**ENVIRONMENT TEST**

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT																																																																		
1	TEMPERATURE RISE TEST	MODEL : SD-15B-5 1. ROOM AMBIENT BURN-IN : 2.5 HRS I/P : 24VDC O/P : FULL LOAD Ta=25.7 °C 2. HIGH AMBIENT BURN-IN : 3.5 HRS I/P : 24VDC O/P : FULL LOAD Ta=40.9 °C			<table border="1"> <thead> <tr> <th>NO</th> <th>Position</th> <th>P/N</th> <th>ROOM AMBIENT Ta= 25.7 °C</th> <th>HIGH AMBIENT Ta= 40.9 °C</th> </tr> </thead> <tbody> <tr><td>1</td><td>LF1</td><td>TF-6003</td><td>55.8°C</td><td>76.3°C</td></tr> <tr><td>2</td><td>R2</td><td>2W 10Ω 5%</td><td>75.9°C</td><td>93.4°C</td></tr> <tr><td>3</td><td>C11</td><td>2200uF/10V 13*20 GL</td><td>62.6°C</td><td>83.8°C</td></tr> <tr><td>4</td><td>C5</td><td>220uF/63V 10*20 GL</td><td>57.9°C</td><td>78.1°C</td></tr> <tr><td>5</td><td>U1</td><td>TL3845</td><td>58.8°C</td><td>80.8°C</td></tr> <tr><td>6</td><td>D2</td><td>HER203 2A/200V</td><td>83.8°C</td><td>105.9°C</td></tr> <tr><td>7</td><td>Q1</td><td>IRF640 18A/200V</td><td>82.8°C</td><td>103.2°C</td></tr> <tr><td>8</td><td>T1</td><td>TF-6041</td><td>77.5°C</td><td>98.9°C</td></tr> <tr><td>9</td><td>T2</td><td>TF-6040</td><td>59.3°C</td><td>78.9°C</td></tr> <tr><td>10</td><td>C33</td><td>330uF/35V 10*16 GL</td><td>55.4°C</td><td>75.5°C</td></tr> <tr><td>11</td><td>D10</td><td>YG865C10R 20A/100V</td><td>79.4°C</td><td>99.8°C</td></tr> <tr><td>12</td><td>R11</td><td>1W 82Ω 5%</td><td>73.3°C</td><td>91.5°C</td></tr> </tbody> </table>	NO	Position	P/N	ROOM AMBIENT Ta= 25.7 °C	HIGH AMBIENT Ta= 40.9 °C	1	LF1	TF-6003	55.8°C	76.3°C	2	R2	2W 10Ω 5%	75.9°C	93.4°C	3	C11	2200uF/10V 13*20 GL	62.6°C	83.8°C	4	C5	220uF/63V 10*20 GL	57.9°C	78.1°C	5	U1	TL3845	58.8°C	80.8°C	6	D2	HER203 2A/200V	83.8°C	105.9°C	7	Q1	IRF640 18A/200V	82.8°C	103.2°C	8	T1	TF-6041	77.5°C	98.9°C	9	T2	TF-6040	59.3°C	78.9°C	10	C33	330uF/35V 10*16 GL	55.4°C	75.5°C	11	D10	YG865C10R 20A/100V	79.4°C	99.8°C	12	R11	1W 82Ω 5%	73.3°C	91.5°C	P
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2	OVER LOAD BURN-IN TEST	NO DAMAGE 1 HOUR (MIN)	I/P : 24 VDC O/P : 135.18 % LOAD Ta : 25°C	TEST : OK	P																																																																		
3	LOW TEMPERATURE TURN ON TEST	TURN ON AFTER 2 HOUR	I/P : 36VDC/18VDC O/P : FULL LOAD Ta= -5°C	TEST : OK	P																																																																		

4	HIGH HUMIDITY HIGH TEMPERATURE HIGH VOLTAGE TURN ON TEST	AFTER 12 HOURS IN CHAMBER ON CONTROL 40 °C NO DAMAGE	I/P : 36 VDC O/P : FULL LOAD Ta= 40 °C HUMIDITY= 95 %R.H	TEST : OK	P
5	TEMPERATURE COEFFICIENT	± 0.05 % (0-50°C)	I/P : 24 VDC O/P : FULL LOAD	± 0.004 % (0-50°C)	P
6	STORAGE TEMPERATURE TEST	1. Thermal shock Temperature : -25°C ~ +90°C 2. Temperature change rate : 25°C / MIN 3. Dwell time low and high temperature : 30 MIN/EACH 4. Total test cycle : 5 CYCLE 5. Input/Output condition : STATIC		OK	P
7	THERMAL SHOCK TEST	1. Thermal shock Temperature : -5°C ~ +45°C 2. Temperature change rate : 25°C / MIN 3. Dwell time low and high temperature : 30 MIN/EACH 4. Total test cycle : 10 CYCLE 5. Input/Output condition : 24VDC/Full Load AC ON/OFF TEST turn on 58sec ; turn off 2sec		OK	P
8	VIBRATION TEST	1 Carton & 1 Set (1) Waveform : Sine Wave (2) Frequency : 10-500Hz (3) Sweep Time : 12min/sweep cycle (4) Acceleration : 2G (5) Test Time : 72min in each axis (X.Y.Z) (6) Ta : 25°C		TEST : OK	P
9	CAPACITOR LIFE CYCLE	SD-15B-5 :SUPPOSE C11 IS THE MOST CRITICAL COMPONENT (1) I/P : 24VDC O/P : FULL LOAD Ta=25 °C LIFE TIME (2) I/P : 24VDC O/P : FULL LOAD Ta=40 °C LIFE TIME (3) I/P : 24VDC O/P : 75% LOAD Ta=40 °C LIFE TIME		(1) 145585.9 HRS (2) 33974.9 HRS (3) 50045.2 HRS	P
10	MTBF	MIL-HDBK-217F NOTICES2 PARTS COUNT TOTAL FAILURE RATE : 652.5KHRS			P

DATE	SAMPLE	TEST RESULT	TESTER	APPROVAL
2005/09/03	PRODUCT SAMPLE	PASS	LIUWY	WANGDZ

2003/08/04 A50-G058